

**Search Notes**

Application/Control No.

10/067,981

Examiner

Jacob Meek

Applicant(s)/Patent under  
Reexamination

OHSAWA, SUSUMU

Art Unit

2637

**SEARCHED**

Class	Subclass	Date	Examiner
375	347,267 260	5/26/2005	jm
455	273,137	5/26/2005	JM
455	45,134	5/26/2005	JM
455	277.1,456	5/26/2005	JM
455	277.2,135	5/26/2005	JM
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**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	5/26/2005	JM